Notice of References Cited Application/Control No. 10/681,517 Examiner Hai L. Nguyen Applicant(s)/Patent Under Reexamination LO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-6,710,664	03-2004	Humphreys et al.	331/11
Х	В	US-6,597,249	07-2003	Chien et al.	331/177R
X	С	US-6,566,966	05-2003	Bellaouar et al.	331/10
Х	D	US-6,545,547	04-2003	Fridi et al.	331/16
Х	E	US-6,483,390	11-2002	Welland, David R.	331/36C
Х	F	US-6,380,810	04-2002	Sutton, Brian P.	331/17
X	G	US-6,163,684	12-2000	Birleson, Vince	455/182.3
Х	н	US-5,696,468	12-1997	Nise, Benjamin E.	331/14
Х	ı	US-5,379,002	01-1995	Jokura, Jun	331/10
X	J	US-5,375,148	12-1994	Parker et al.	375/376
X	К	US-5,363,419	11-1994	Ho, Kenneth S.	375/376
Х	L	US-4,590,602	05-1986	Wolaver, Dan H.	375/375
Х	М	US-4,272,729	06-1981	Riley, Jr., William J.	331/1A

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	-				
	0					
	Р					
	Q					
	R			·		<u>.</u>
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.